

STE30NK90Z

N-channel 900V - 0.21Ω - 28A ISOTOP Zener-Protected SuperMESH™ MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D	Pw
STE30NK90Z	900V	<0.26Ω	28A	500W

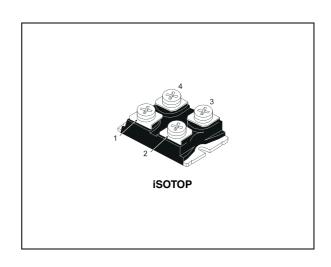
- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized

Description

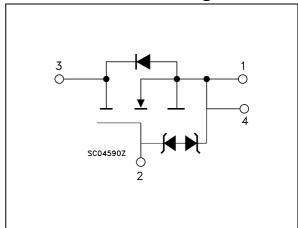
The SuperFREDMesh™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Marking Package	
STE30NK90Z	E30NK90Z	ISOTOP	TUBE

Contents STE30NK90Z

Contents

1	Electrical ratings
2	Electrical characteristics
	2.1 Protection features of gate-to-source zener diodes
	2.2 Electrical characteristics (curves)
3	Test circuit
4	Package mechanical data1
5	Revision history

STE30NK90Z Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	900	V
V _{DGR}	Drain-gate voltage (R_{GS} = 20 kΩ)	900	V
V _{GS}	Gate- source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25°C	28	А
I _D	Drain current (continuous) at T _C = 100°C	18	Α
I _{DM} ⁽¹⁾	I _{DM} ⁽¹⁾ Drain current (pulsed)		А
P _{tot}	Total dissipation at T _C = 25°C	500	W
	Derating Factor	4.3	W/°C
V _{ESD(G-S)}	Gate source ESD(HBM-C=100pF, R=1.5KW)	6.5	KV
dv/dt (2)	Peak diode recovery voltage slope	4.5	V/ns
V _{ISO}	Insulation withstand voltage (AC-RMS) from all four terminals to external heatsink	` ' 2500	
T _{stg}	Storage temperature	-65 to 150	°C
Tj	Max. operating junction temperature	-03 to 150	O

^{1.} Pulse width limited by safe operating area.

Table 2. Thermal data

Rthj-case	Thermal resistance junction-case max	0.23	°C/W
Rthj-amb	Thermal resistance junction-ambient max	40	°C/W

Table 3. Avalanche characteristics

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T _j Max)	13	Α
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 35$ V)	500	mJ

^{2.} $I_{SD} \leq 28A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$,

Electrical characteristics STE30NK90Z

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	900			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating, T_{C} = 125 °C			10 100	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20V			±100	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$	3	3.75	4.5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 14 A		0.21	0.26	Ω

Table 5. Dynamic

	, ,	 				
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15 V _, I _D = 14 A		26		S
C _{iss} C _{oss} C _{rss}	Input capacitance output capacitance reverse transfer capacitance	$V_{DS} = 25V, f = 1 \text{ MHz}, $ $V_{GS} = 0$		12000 852 166		pF pF pF
Coss eq. (2)	Equivalent output capacitance	$V_{GS} = 0V,$ $V_{DS} = 0V \text{ to } 720 \text{ V}$		377		pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time rise time turn-off delay time fall time	$V_{DD} = 450 \text{ V}, I_{D} = 13 \text{ A}$ $R_{G} = 4.7\Omega V_{GS} = 10 \text{ V}$ (see <i>Figure 14</i>)		67 59 250 72		ns ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge gate-source charge gate-drain charge	$V_{DD} = 720 \text{ V}, I_{D} = 26 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see <i>Figure 15</i>)		350 51 190	490	nC nC nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %

^{2.} $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)				28 112	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 28 A, V _{GS} = 0			2	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 26 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V, T}_j = 25^{\circ}\text{C}$ (see Figure 16)		1 18.9 36.6		μs μC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 26 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V, T}_j = 150^{\circ}\text{C}$ (see Figure 16)		1.33 25.2 37.8		μs μC A

^{1.} Pulse width limited by safe operating area%

Table 7. Gate-source zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate-source breakdown voltage	Igs=± 1mA (Open Drain)	30			٧

2.1 Protection features of gate-to-source zener diodes

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

5/

^{2.} Pulsed: Pulse duration = 300 µs, duty cycle 1.5

Electrical characteristics STE30NK90Z

2.2 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

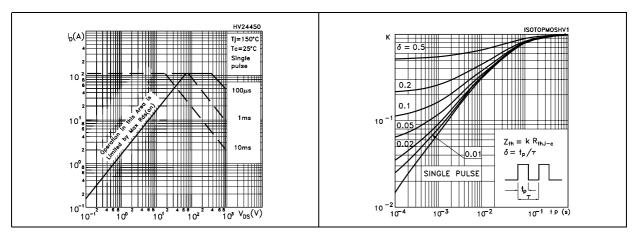


Figure 3. Output characterisics

Figure 4. Transfer characteristics

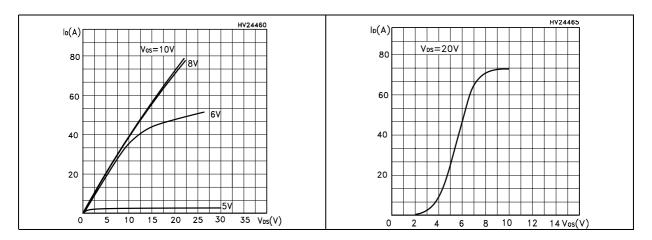


Figure 5. Transconductance

Figure 6. Static drain-source on resistance

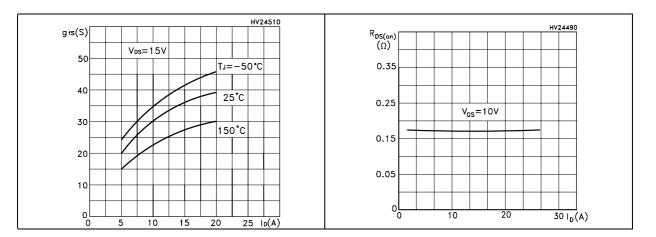


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

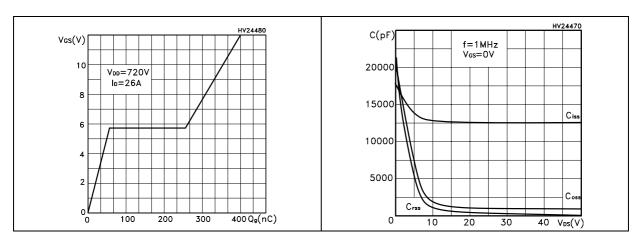


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

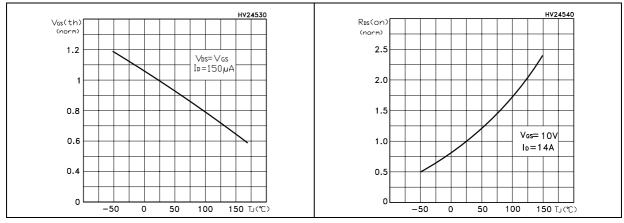
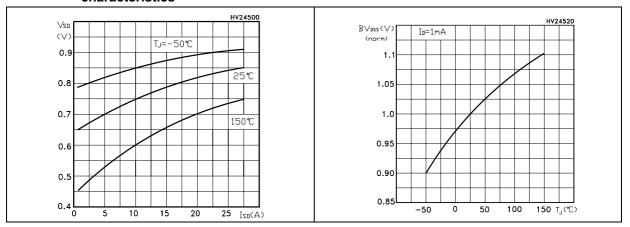


Figure 11. Source-drain diode forward characteristics

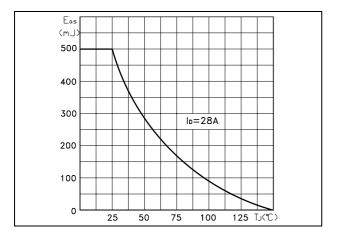
Figure 12. Normalized B_{VDSS} vs temperature



47/

Electrical characteristics STE30NK90Z

Figure 13. Avalanche energy vs starting Tj



STE30NK90Z Test circuit

3 Test circuit

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

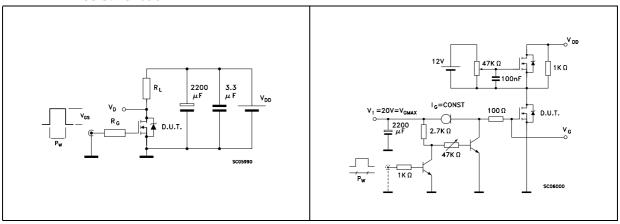


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped Inductive load test circuit

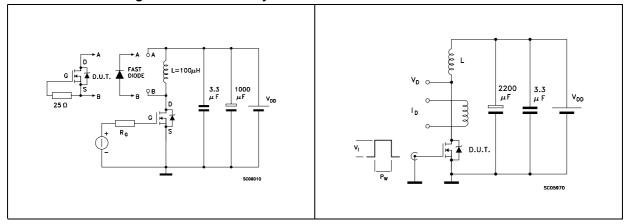
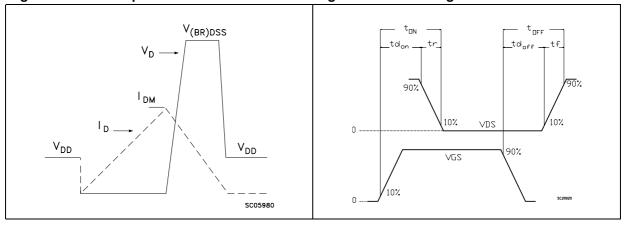


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



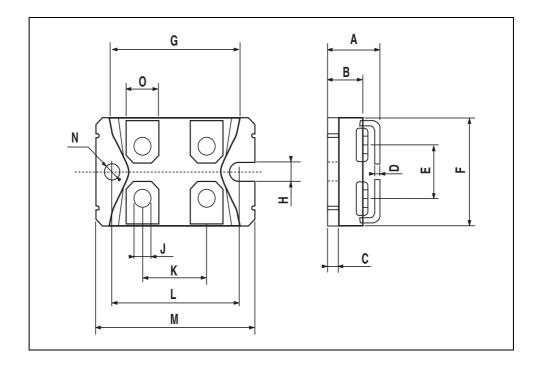
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

577

ISOTOP MECHANICAL DATA

DIM.		mm			inch	
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	11.8		12.2	0.466		0.480
В	8.9		9.1	0.350		0.358
С	1.95		2.05	0.076		0.080
D	0.75		0.85	0.029		0.033
E	12.6		12.8	0.496		0.503
F	25.15		25.5	0.990		1.003
G	31.5		31.7	1.240		1.248
Н	4			0.157		
J	4.1		4.3	0.161		0.169
K	14.9		15.1	0.586		0.594
L	30.1		30.3	1.185		1.193
М	37.8		38.2	1.488		1.503
N	4			0.157		
0	7.8		8.2	0.307		0.322



47/

Revision history STE30NK90Z

5 Revision history

Table 8. Revision history

Date	Revision	Changes
24-May-2005	1	First Release
10-Jun-2005	2	Inserted new row in Table 6.: Switching times
28-Sep-2005	3	Complete version
14-Oct-2005	4	Modified Figure 3, Figure 6
12-Jul-2006	5	New template, no content change

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2006 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

